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## **Supporting information**

**Supplementary Material S1**: Intensity distribution profiles of the incident azimuthally (left) or radially (right) polarized beam in the focal region. The profiles were calculated for a 1064 nm incident beam corresponding to the two different objectives employed in this work with numerical apertures of respectively 0.9 in air (top) and of 1.3 in oil (bottom)



**Supplementary Material S2**: Schematic of  $\Delta n$  estimation taking into account topology corrections.



d<sub>x</sub>: topological depth (measured by AFM)

d >>>  $d_x$  and can be considered to be 2.5  $\mu$ m (poled layer measured by SHG

microscopy) [38]

 $n_1 = 1.83$  (measured by the Brewster angle) [38]

 $OP_1 = n_1.d$   $OP_x = n_x.(d-d_x) + n_{air}.d_x = n_1.(d-d_x) + d_x$   $OPD = OP_x - OP_1$ Then:

 $n_x = \frac{OPD - dx + n_1.d}{d - dx}$ 

And:

 $\Delta n = n_{x} - n_{1}$ 

Sample	G-70/4	G-4/4
$n_1$	1.83	1.83
d	2.5 μm	2.5 μm
$d_x$ (Figure 5)	100 nm	75 nm
OPD (Figure 6)	60 nm	45 nm
n <sub>x</sub>	1.839	1.837
Δn	0.009	0.007